Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10526337	NAKAMURA ET AL.
Examiner	Art Unit
Khoa D Huynh	3751

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
updated previous search	7/28/08	HK		

INTERFERENCE SEARCH				
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